Application/Control No. Applicant(s)/Patent Under Reexamination 10/619,434 BEHFAR, ALEX A. Notice of References Cited Examiner Art Unit Page 1 of 1 John D. Lee 2874 U.S. PATENT DOCUMENTS **Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-4,807,953 02-1989 Α Smith et al. 385/27 US-4,829,528 В 05-1989 Band et al. 372/3 С US-5,027,361 06-1991 Kozlovsky et al. 372/22 US-2002/0063944 05-2002 D Kim et al. 359/326 US-Ε F US-US-G Н US-1 US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 8-186540 07-1996 Japan Furukawa H04B 10/152 0 Ρ Q .R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.